

**Notice of References Cited**

Application/Control No.

09/222,906

Applicant(s)/Patent Under  
Reexamination  
DELEEUEW, WILLIAM C.

Examiner

Cong-Lac Huynh

Art Unit

2178

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,031,625	02-2000	Sherman et al.	358/1.18
	B	US-6,188,807	02-2001	Arakawa, Naoto	382/319
	C	US-6,249,794	06-2001	Raman, T. V.	715/500
	D	US-6,298,357	10-2001	Wexler et al.	715/513
	E	US-6,445,462	09-2002	Aritomi, Masanori	358/1.9
	F	US-5,995,986	11-1999	Ueda et al.	715/516
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.